

Search Notes**Application/Control No.**

10/524,182

Examiner

Hieu P. Nguyen

Applicant(s)/Patent under Reexamination

REDMAN-WHITE ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	281	8/29/2006	HN
330	284-285	8/29/2006	HN
330	144-145	8/29/2006	HN

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
MOTTOLA STEVEN J	8/27/2006	HN
EAST UPDATE SEARCH	12/18/2006	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
US-PGPUB		12/18/2006	HN